

Notice of References Cited

Application/Control No.

10/540,559

Applicant(s)/Patent Under
Reexamination
IIZUKA ET AL.

Examiner

Mark Kopec

Art Unit

1796

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0016531	08-2001	Morikoshi et al.	474/237
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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